

**Search Notes**

Application/Control No.

10/804,164

Examiner

Yaritza Guadalupe McCall

Applicant(s)/Patent under  
Reexamination

FUJII ET AL.

Art Unit

2859

**SEARCHED**

Class	Subclass	Date	Examiner
399	252 - 255	1/23/2006	YG
399	258, 260	1/23/2006	YG
399	262	1/23/2006	YG

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Updated	as above	1/23/2006	YG

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Previous searches were updated	1/23/2006	YG